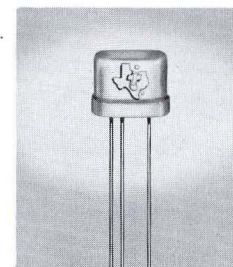


TYPE 2N1107 P-N-P GROWN-DIFFUSED GERMANIUM TRANSISTOR



TYPE 2N1107
BULLETIN NO. DL-S 1017, FEBRUARY, 1959

RF AMPLIFIER FOR BROADCAST-BAND RECEIVERS



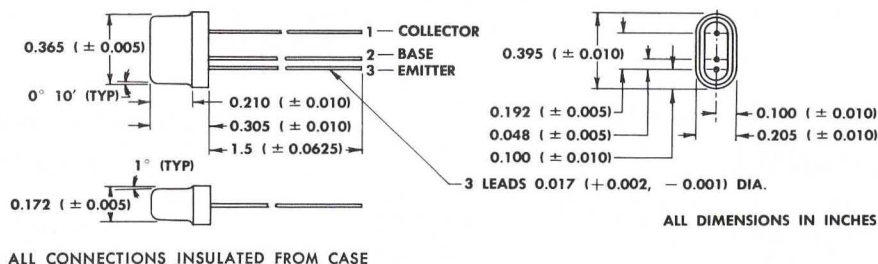
ACTUAL SIZE

qualification testing

To assure maximum reliability, stability and long life, all units are heat cycled from -55°C and room humidity to $+75^{\circ}\text{C}$ and 95% relative humidity for four complete cycles over an eight-hour period. All transistors are thoroughly tested for rigid adherence to specified design characteristics.

mechanical data

Metal case with glass-to-metal hermetic seal between case and leads. Unit weight is 1 gram.



absolute maximum ratings at 25°C case temperature (unless otherwise noted)

Collector-to-Base Voltage	16 v
Collector Current	5 ma
Total Dissipation	30 mw
Collector Junction Temperature	$+85^{\circ}\text{C}$
Storage Temperature Range	-55°C to $+85^{\circ}\text{C}$

typical design characteristics at 25°C

				typical	max.	unit
I_{CB0}	Collector Reverse Current	$I_E = 0$	$V_{CB} = -12\text{ v}$	-5	-10	μa
h_{fe}	Forward Current Transfer Ratio (455 kc)	$I_C = -0.5\text{ ma}$	$V_{CB} = -6\text{ v}$	34	—	db
$f_{\alpha b}$	Current Transfer Ratio Cutoff Frequency	$I_C = -1\text{ ma}$	$V_{CB} = -5\text{ v}$	40	—	mc
C_{ob}	Output Capacitance	$I_C = -1\text{ ma}$	$V_{CB} = -6\text{ v}$	1.5	—	μf

LICENSED UNDER BELL SYSTEM PATENTS

SEMICONDUCTOR-COMPONENTS DIVISION

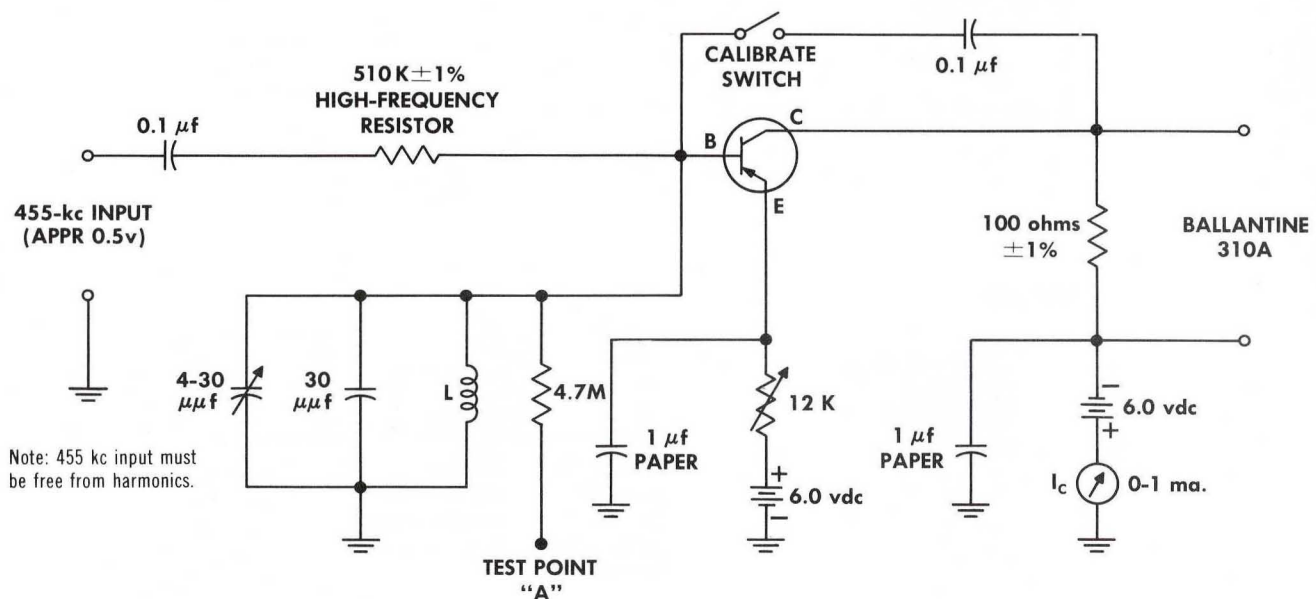
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TYPE 2N1107

TEST CIRCUIT

455 - kc h_{fe} TEST SET



Coil Data

$L = 2.5$ mh
 $Q = 150$ minimum at 455 kc
260 turns of #32 wire random wound on general ceramics
#F624-2 steatite Q, toroid core with one layer of insulated tape on bare core.

455-kc h_{fe} Test Set Operating Instructions

1. Connect a VTVM to test point "A" and adjust the 455-kc tuned circuit for resonance.
2. Close calibrate switch and adjust 455-kc input to give 0.1 mv reading on Ballantine 310A or equivalent.
3. Open calibrate switch, insert transistor, and set $I_C = 0.5$ ma.
4. Read h_{fe} value directly in db (0 db = 0.1 mv reference level).

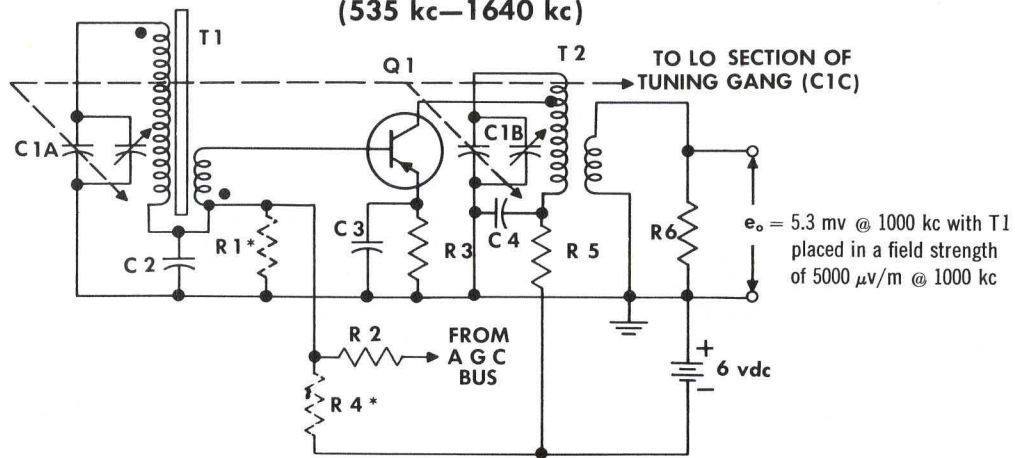
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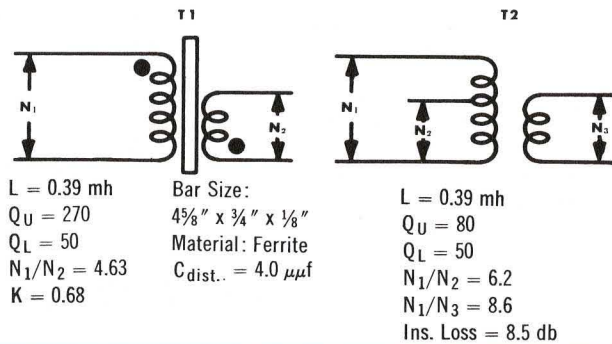
TYPICAL TUNED RF AMPLIFIER
(535 kc—1640 kc)



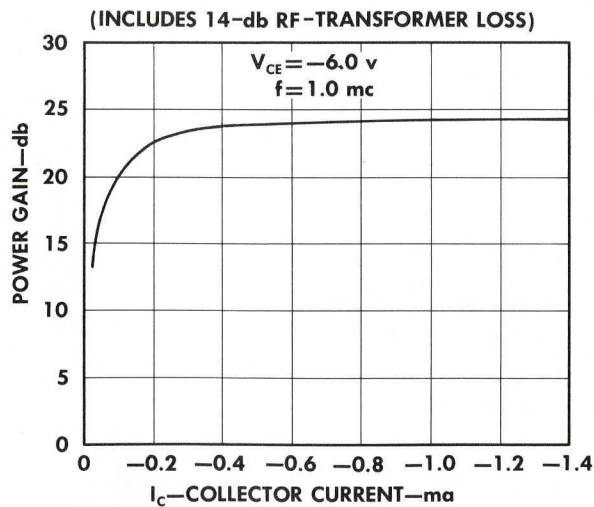
PARTS LIST:

- * R1 = 1.8 K ohms
- R2 = 1.0 K ohms
- R3 = 1.8 K ohms
- * R4 = 18 K ohms
- R5 = 470 ohms
- R6 = 5.0 K ohms
- C 1A, B = 22-242 $\mu\mu\text{f}$
- C 2 = 0.01 μf
- C 3, 4 = 0.05 μf
- Q 1 = 2N1107

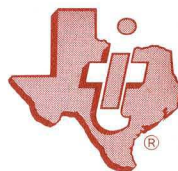
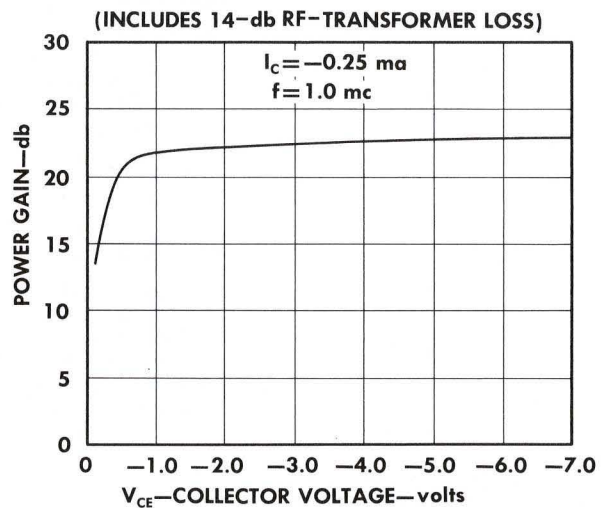
* To Be Used When AGC Is Not Desired



TYPICAL POWER GAIN VS COLLECTOR CURRENT



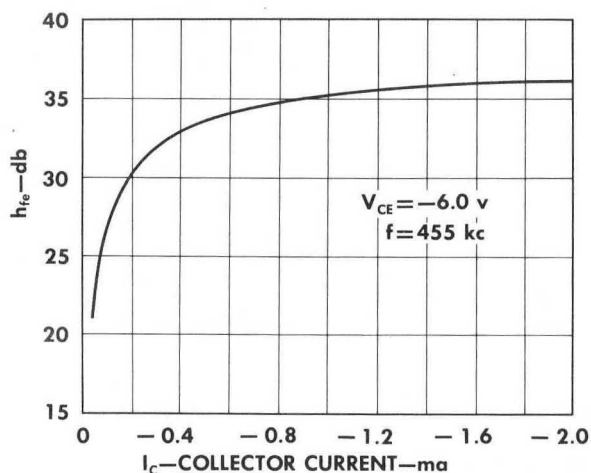
TYPICAL POWER GAIN VS COLLECTOR VOLTAGE



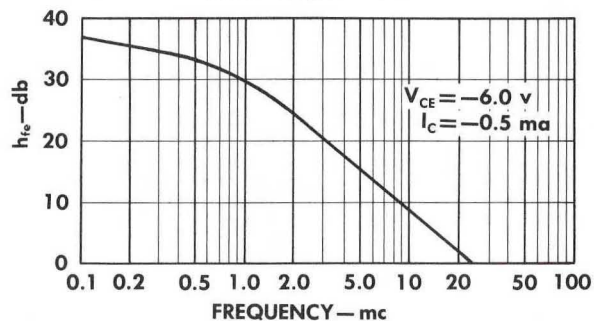
TYPE 2N1107

TYPICAL CHARACTERISTICS

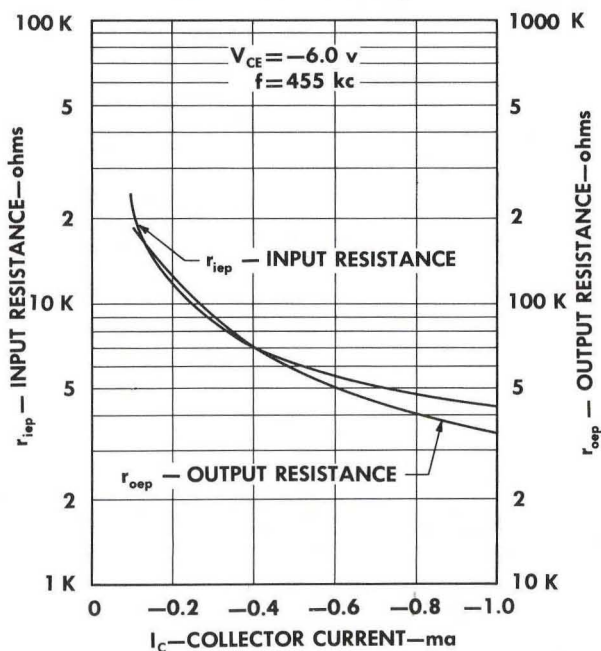
TYPICAL CURRENT AMPLIFICATION (h_{fe})
VS COLLECTOR CURRENT



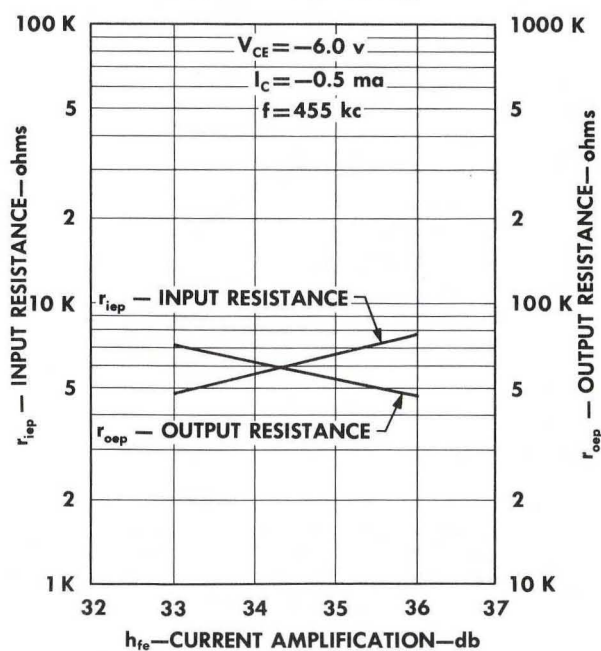
TYPICAL CURRENT AMPLIFICATION (h_{fe})
VS FREQUENCY



TYPICAL INPUT AND OUTPUT
RESISTANCE VS I_C



TYPICAL INPUT AND OUTPUT
RESISTANCE VS h_{fe}



r_{iep} = Common-emitter parallel input resistance with output shorted
 r_{oep} = Common-emitter parallel output resistance with input shorted

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